



Time Domain Reflectometry (TDR) and S-parameter

“Measurements and Best Practice for Signal Integrity”



Agenda

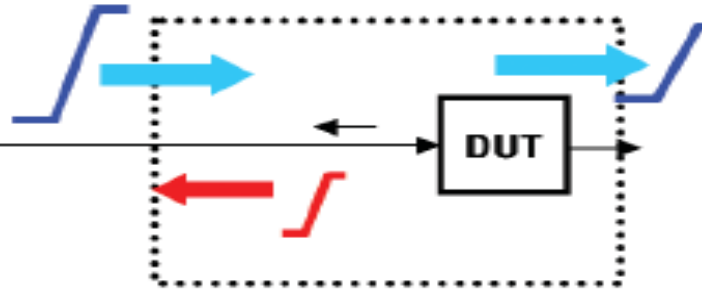
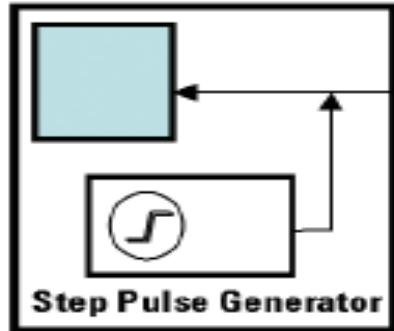


- ❑ **Time Domain Reflectometry**
 - ❑ TDR and TDT measurements
 - ❑ True Differential measurements definition
 - ❑ Deskew
 - ❑ Reference Plane Calibration (SL vs. OSL)
- ❑ **S-parameters**
 - ❑ Concept and Definition
- ❑ **Return Loss and Insertion Loss**
- ❑ **Cross-talk interference**
 - ❑ NEXT and FEXT concepts
- ❑ **Introduction to mixed-mode S-parameters**

What is TDR ?

TDR - Time Domain Reflectometry (TDR)

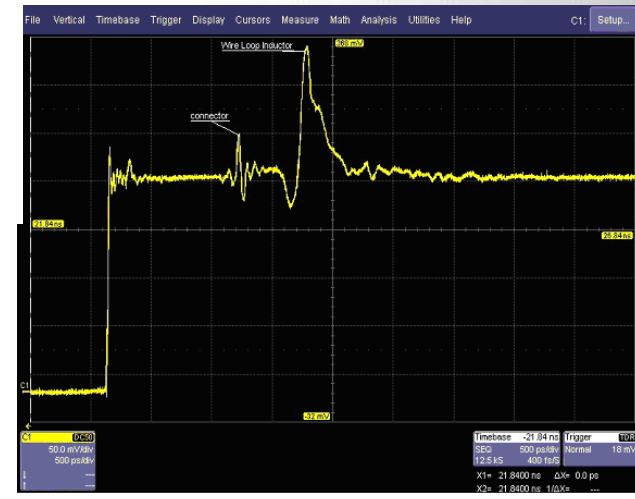
Wideband Oscilloscope



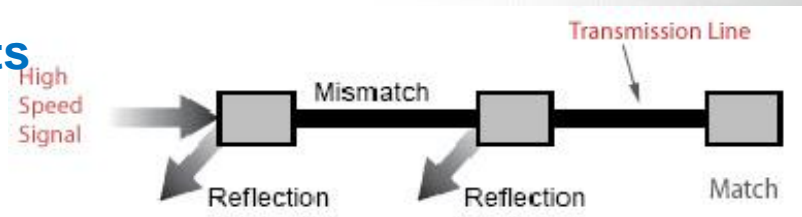
TDR measurements set-up

❖ It is the measurements of the reflection in the time domain

- ✓ A pulse generator is used to provide an incident step pulse (stimulus)
- ✓ Voltage Reflection from the Device Under Test (DUT) is measured by the scope . TDR mismatch
- ✓ Shape of the measured Reflection helps determine the type of discontinuity and its location
 - ❖ TDR measures Discontinuities that cause reflections and their Distance

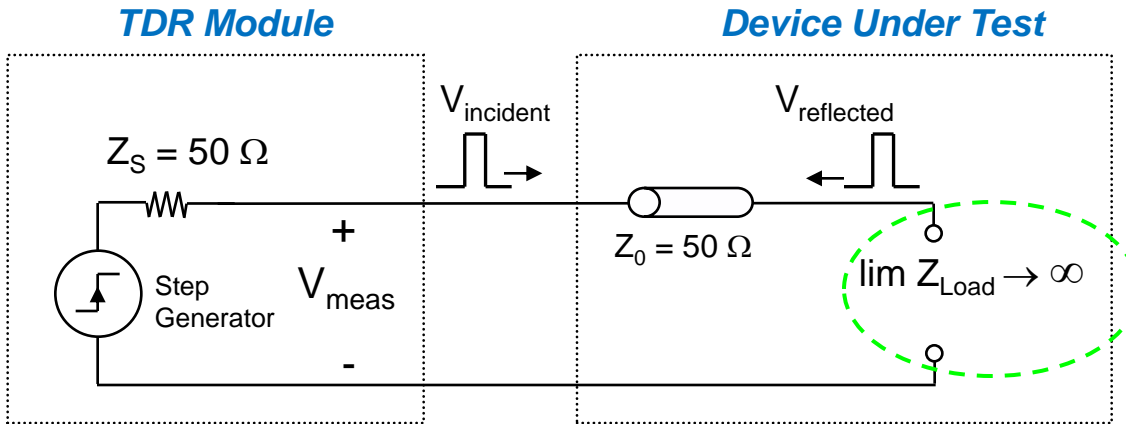


Time



Open Circuit ($Z_{load} \rightarrow \infty$)

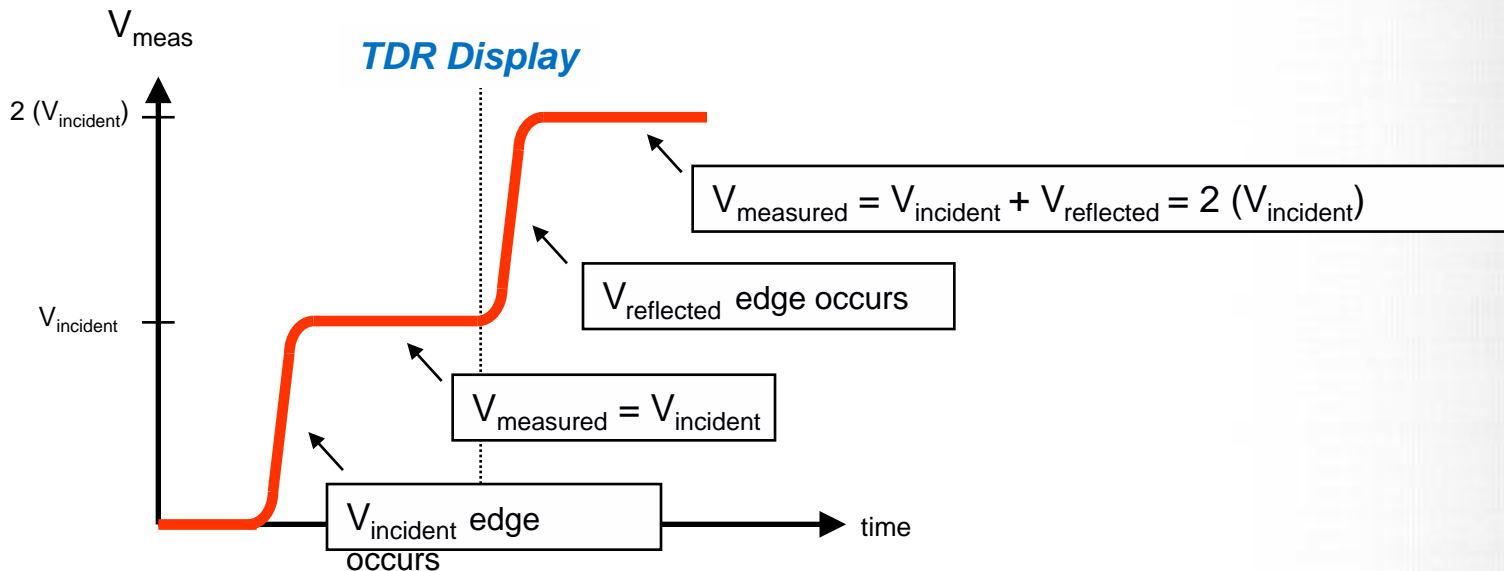
TDR example



Solving for $V_{reflected}$:

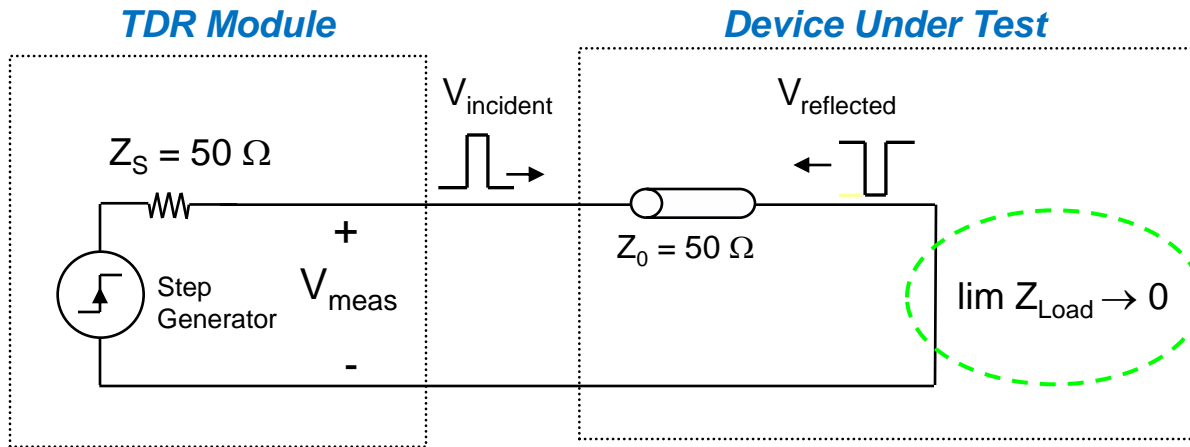
$$V_{reflected} = V_{incident} \left(\frac{Z_{Load} - Z_0}{Z_{Load} + Z_0} \right)$$

$$\lim Z_{Load} \rightarrow \infty, \therefore V_{reflected} = V_{incident}$$



Short Circuit ($Z_{load} = 0$)

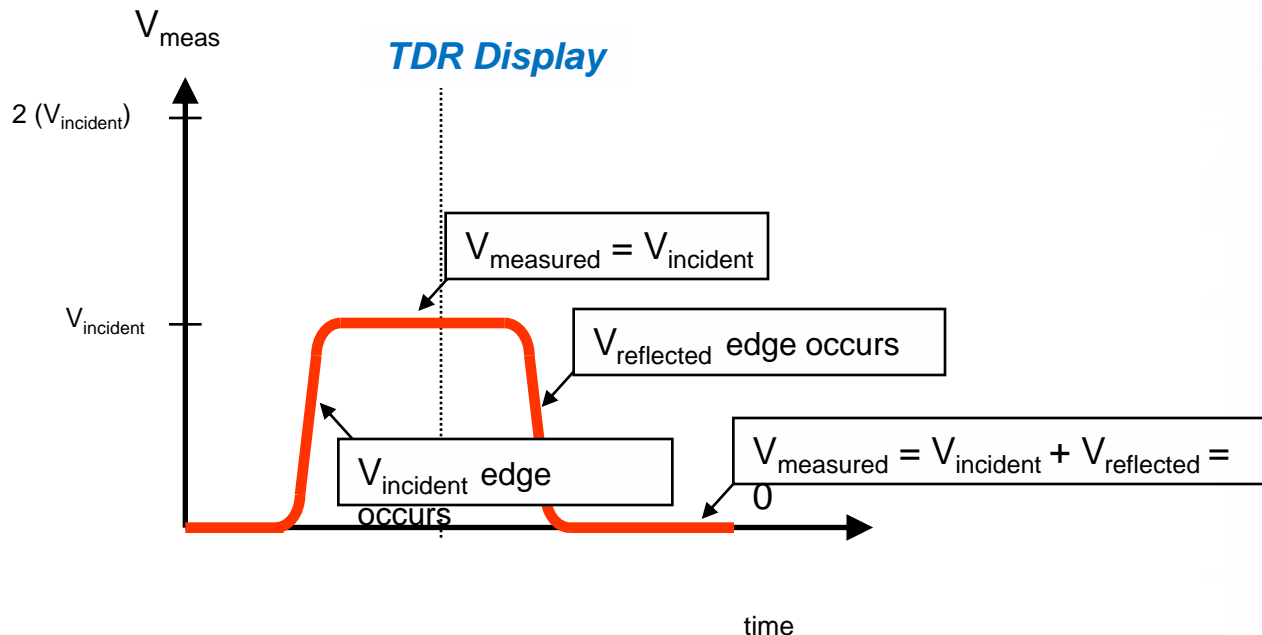
TDR example



Solving for $V_{reflected}$:

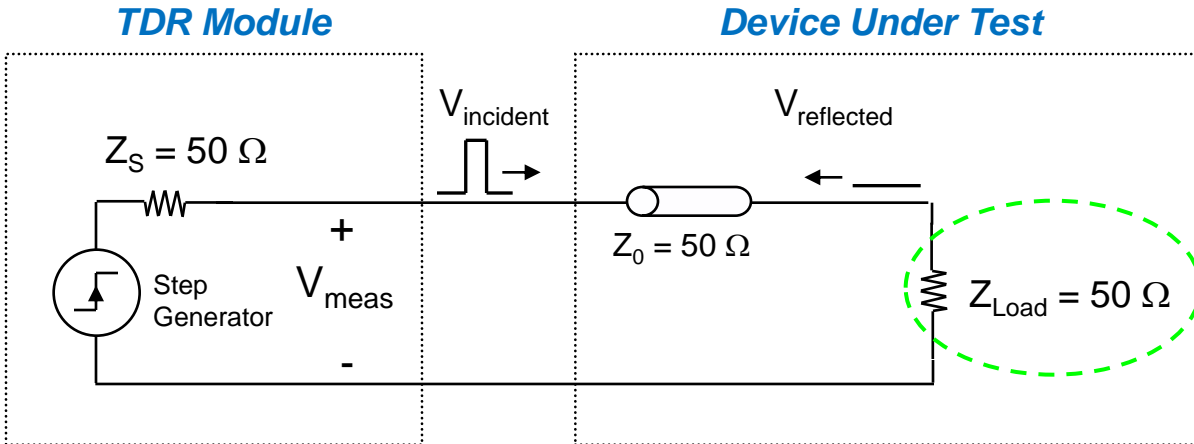
$$V_{reflected} = V_{incident} \left(\frac{Z_{Load} - Z_0}{Z_{Load} + Z_0} \right)$$

$$\lim Z_{Load} \rightarrow 0, \therefore V_{reflected} = -V_{incident}$$



Matched Impedance ($Z_{\text{load}} = 50 \text{ Ohm}$)

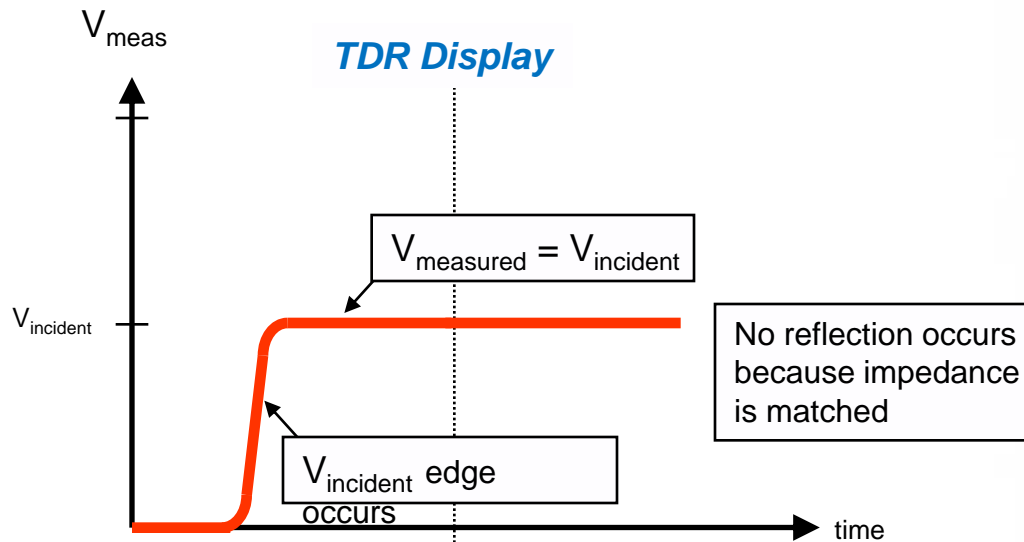
TDR example



Solving for $V_{\text{reflected}}$:

$$V_{\text{reflected}} = V_{\text{incident}} \left(\frac{Z_{\text{Load}} - Z_0}{Z_{\text{Load}} + Z_0} \right)$$

$$Z_{\text{Load}} = Z_0, \therefore V_{\text{reflected}} = 0$$

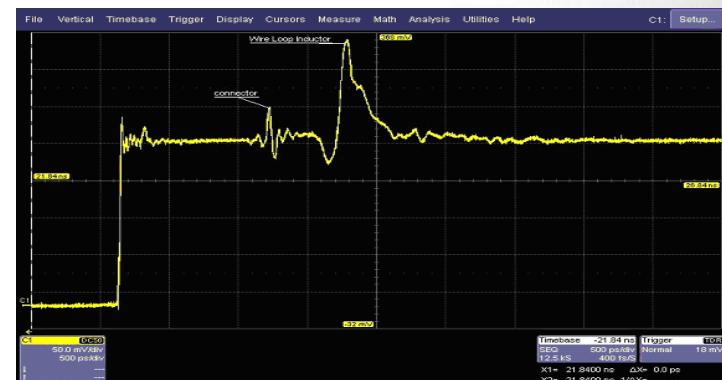
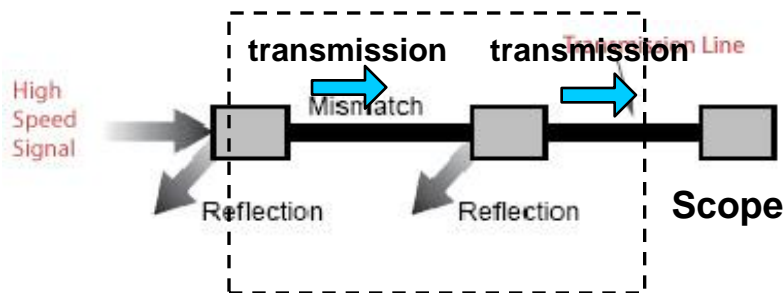
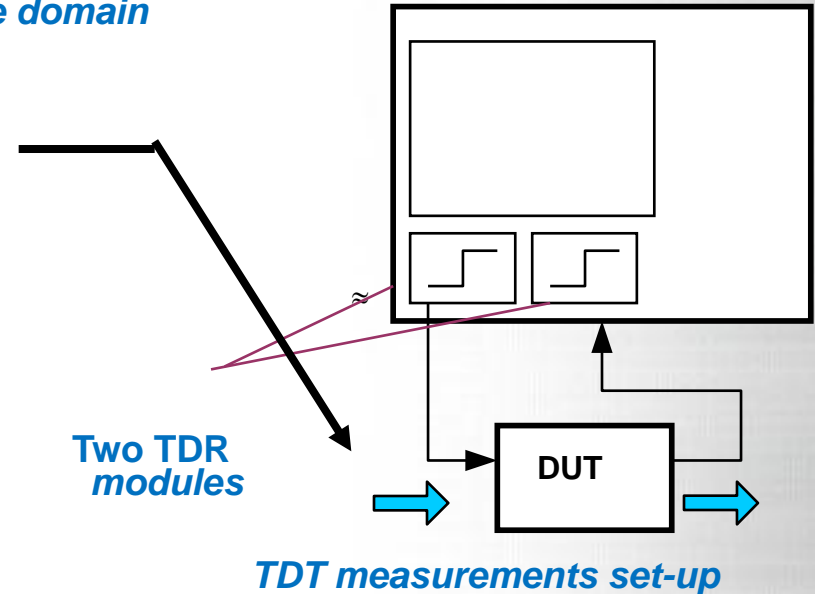


What is TDT?

TDT - Time Domain Transmission (TDT)

❖ It is the measurements of the transmission in the time domain

- ✓ A pulse generator is used to provide an incident step pulse (stimulus)
- ✓ Voltage Transmission from the Device Under Test (DUT) is measured by the scope
- ✓ $TDT \approx$ Insertion (Transmission) Loss
- ✓ Requires two TDR modules – one to generate the step and other to sample



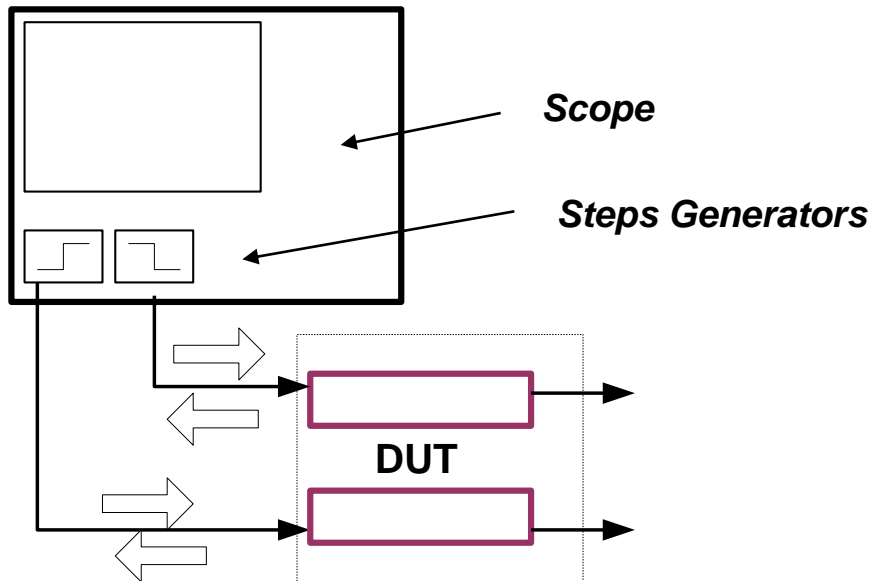
Time →

True Differential TDR / TDT

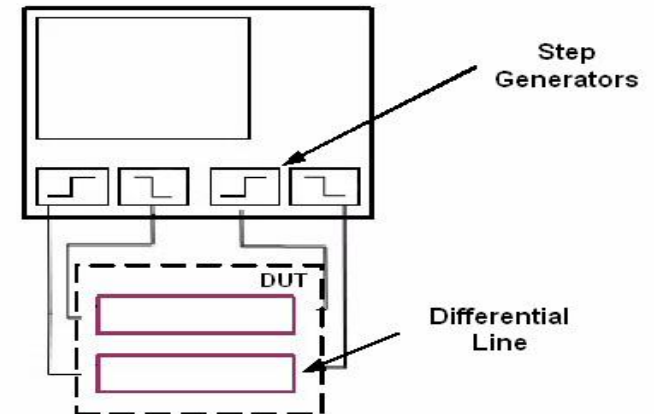
- ✓ *High Speed digital systems are mainly differential*
- ✓ *TDR requires two ST-20 modules to provide the differential signal (stimulus), step pulses, positive and negative (automatically changes polarity when selecting differential)*



- ✓ *De-skew control aligns the two pulses from each of the two ST-20 modules.*
 - ✓ *HW deskew (± 50 ps)*
- ✓ *Requires four TDR modules – two to generate the differential signal and other two to receive the differential signal*



Differential TDR measurements set-up



Differential TDT measurements set-up

Reference Plane Calibration

❖ *Before calibration – effects of test fixture and connectors are included in the response*

Calibration Methods :

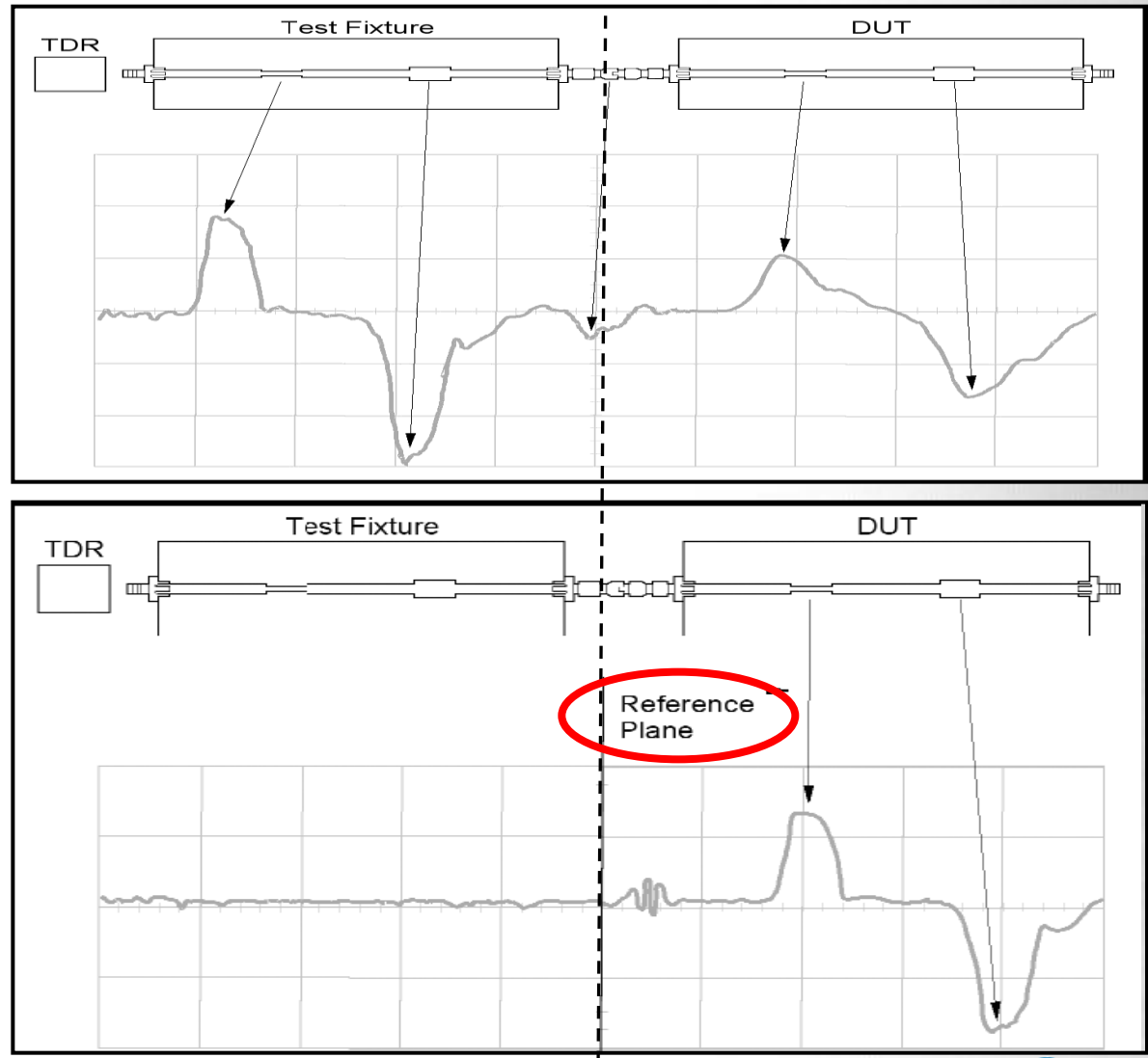
❖ Short Load (SL)

Uses Two known standards (Short & Load)

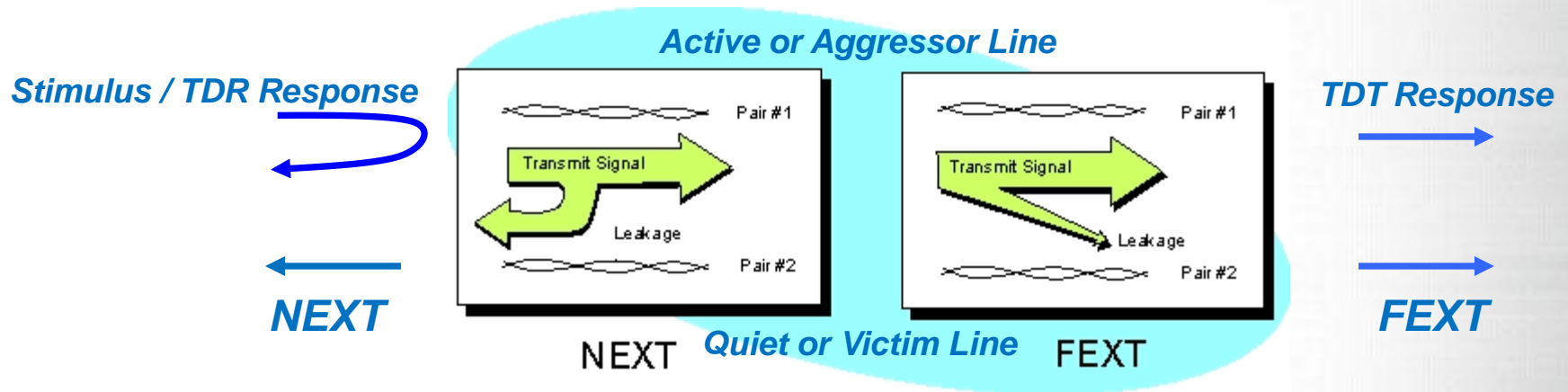
❖ Open Short Load (OSL)

Uses Three known standards (Open , Short & Load)

❖ *After calibration – effects of test fixture and connectors are removed from response*

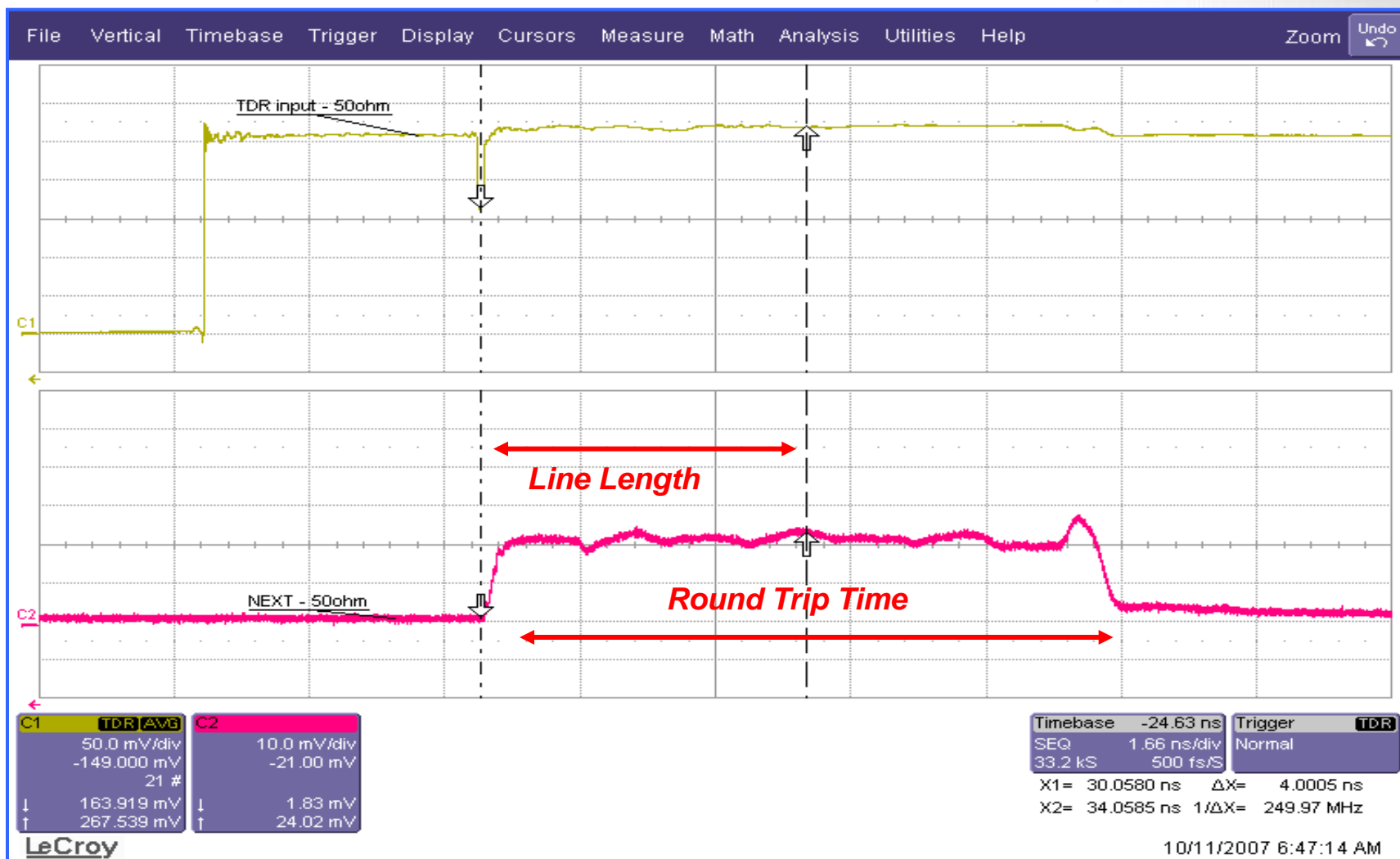


NEXT/FEXT on adjacent transmission lines

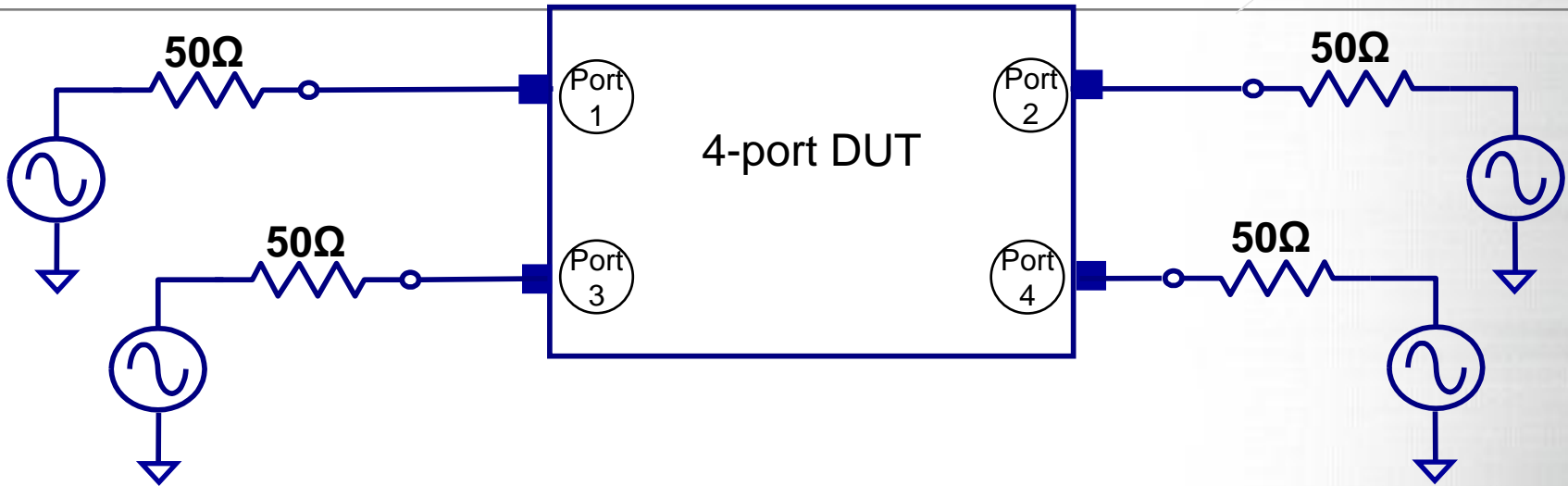


- ❑ **Near-End Cross Talk (NEXT) is the ratio between the voltage measured on the near end on the quiet line and the stimulus.**
- ❑ **Far-End Cross Talk (FEXT) is the ratio between the voltage measured on the far end on the quiet line and the stimulus.**
- ✓ **NEXT-FEXT Cross-talk measured the coupling between two adjacent transmission lines**

NEXT - Quiet Line @ 50Ω



General 4 port Measurement Setup



- ✓ **4-port DUT can be modeled as single-ended or differential**
 - ❖ **Single ended S-parameter measurements for a 4-port network are straightforward—just like 2-port case, only more S-parameters**

$$\begin{bmatrix} S_{11} & S_{12} & S_{13} & S_{14} \\ S_{21} & S_{22} & S_{23} & S_{24} \\ S_{31} & S_{32} & S_{33} & S_{34} \\ S_{41} & S_{42} & S_{43} & S_{44} \end{bmatrix}$$

- ❖ **A 4-port DUT can also be modeled as 2-port differential DUT and in this case represented using “Mixed-Mode” S-Parameters**



Practical Lab

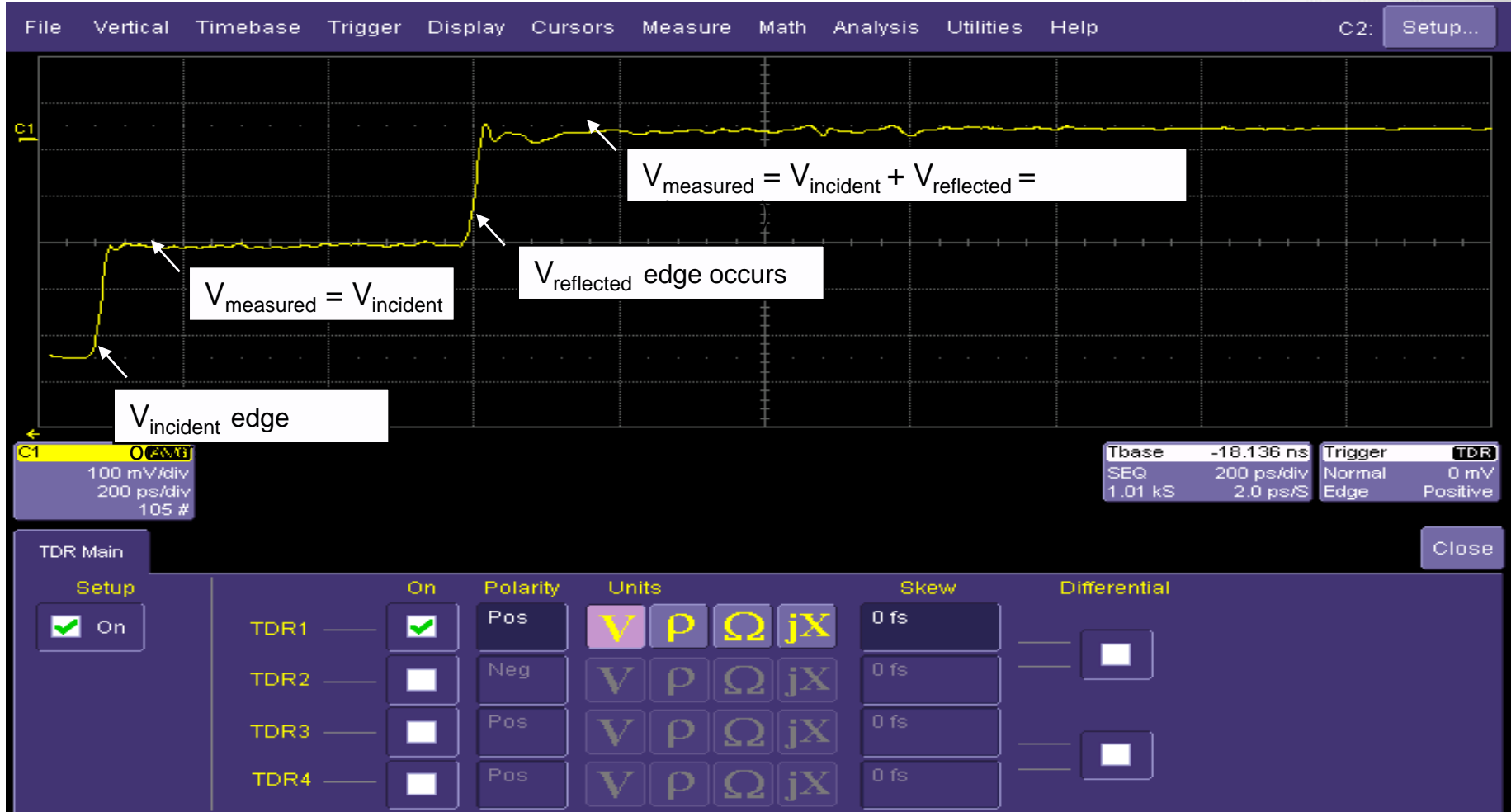
Time Domain Reflectometry (TDR) and S-parameter

“Measurements and Best Practice for Signal Integrity”

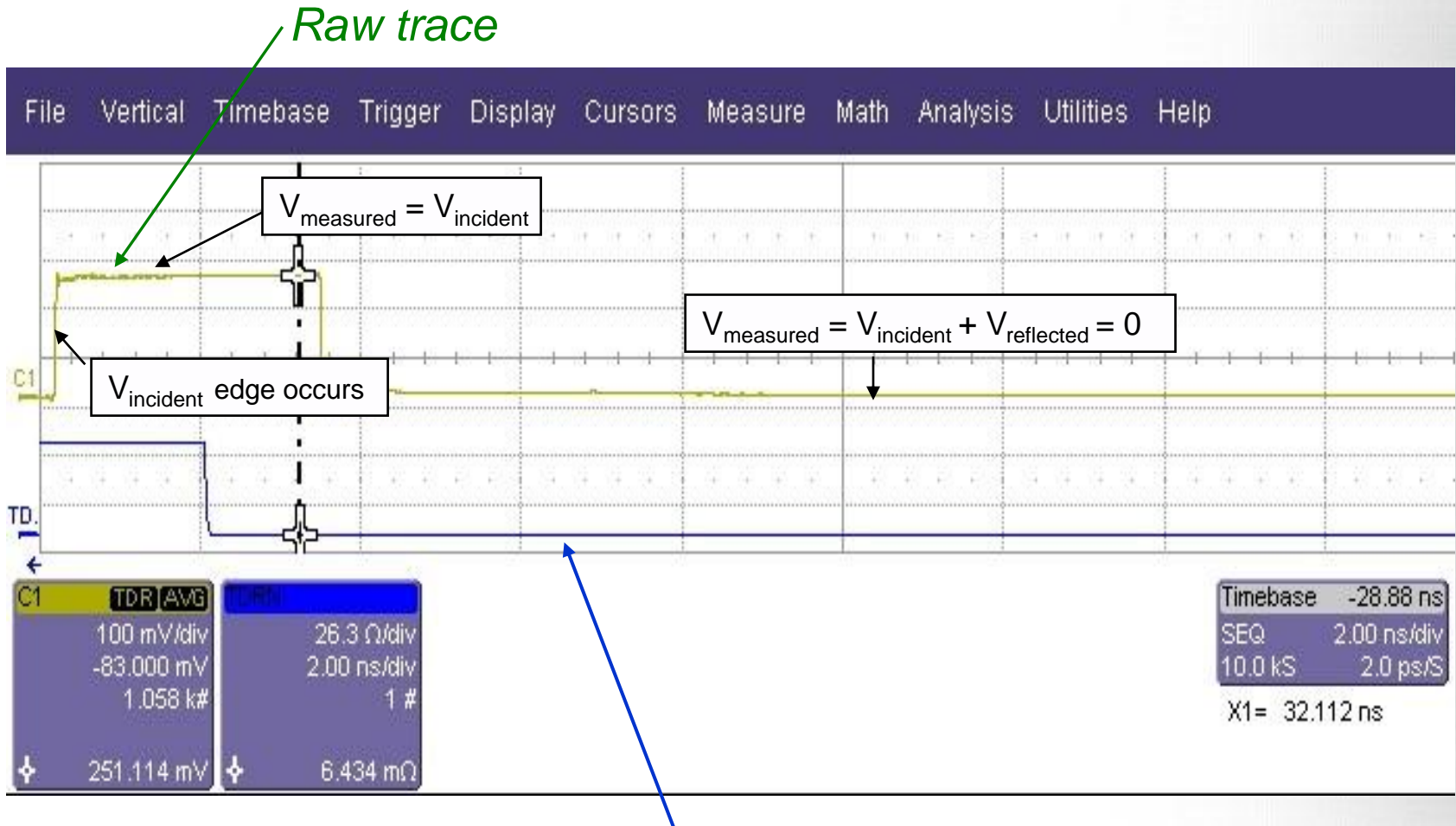


Open in the air

TDR example



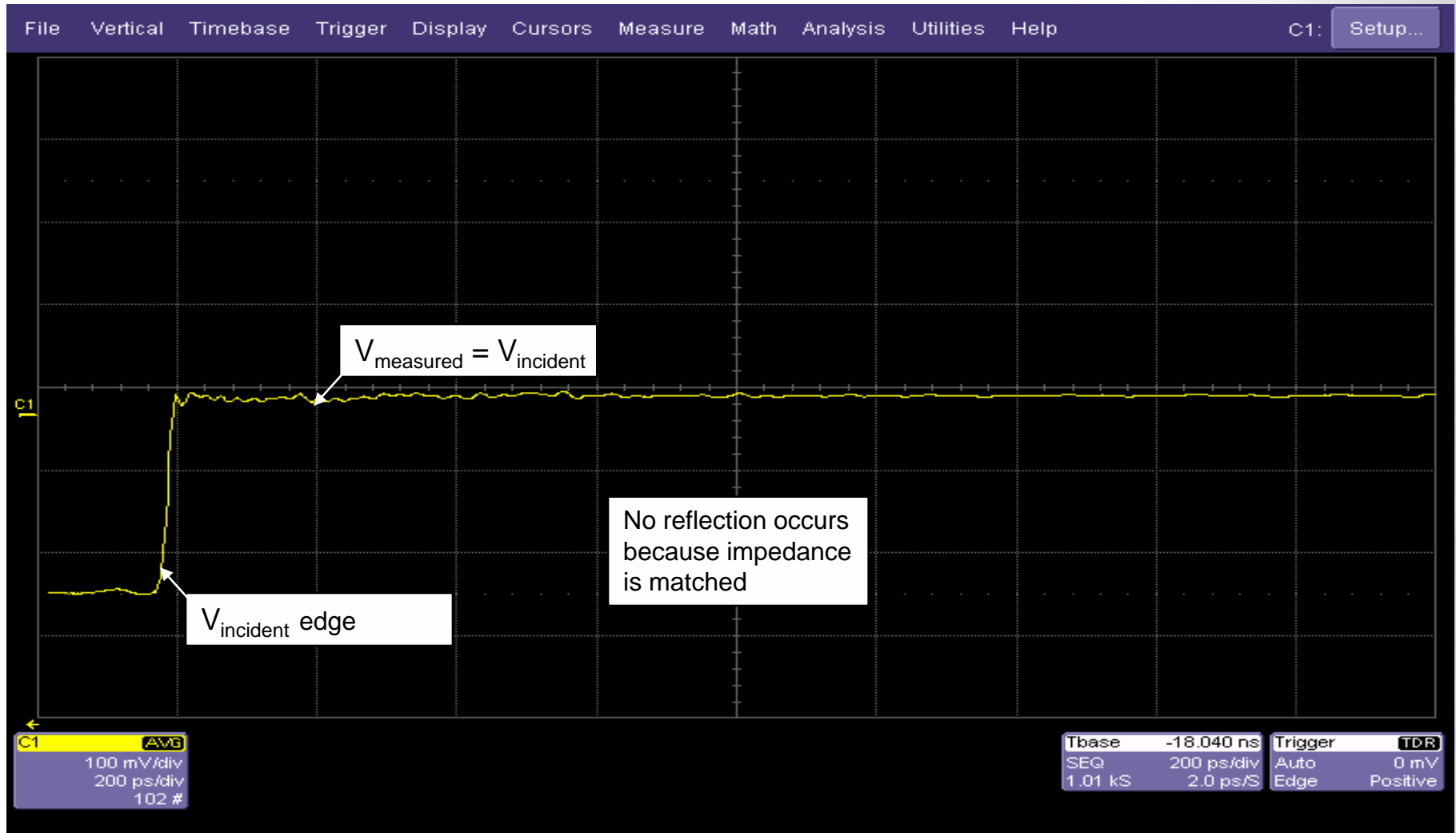
Short terminated ($Z_{load} = 0$) TDR example



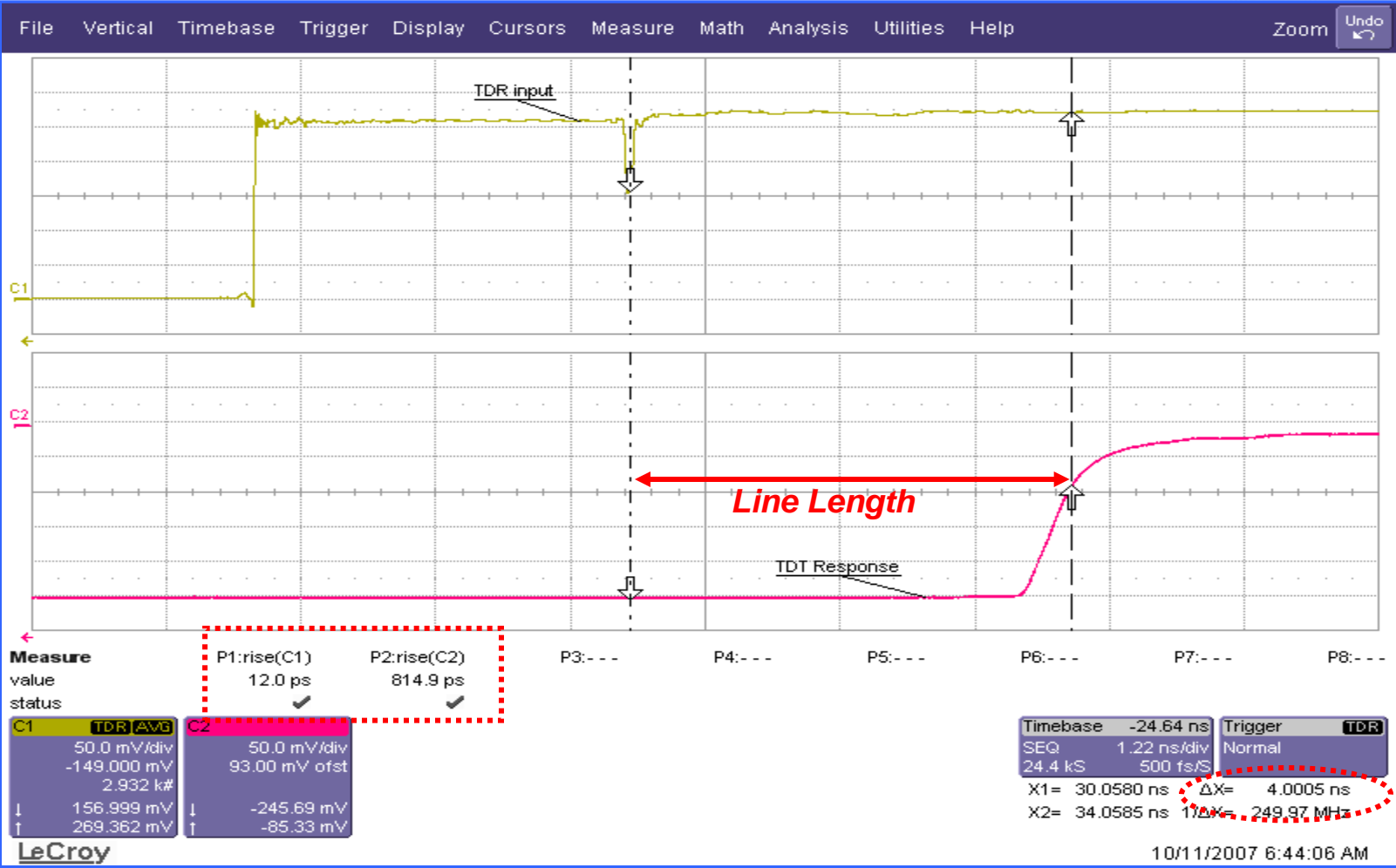
Normalized trace

Matched Impedance

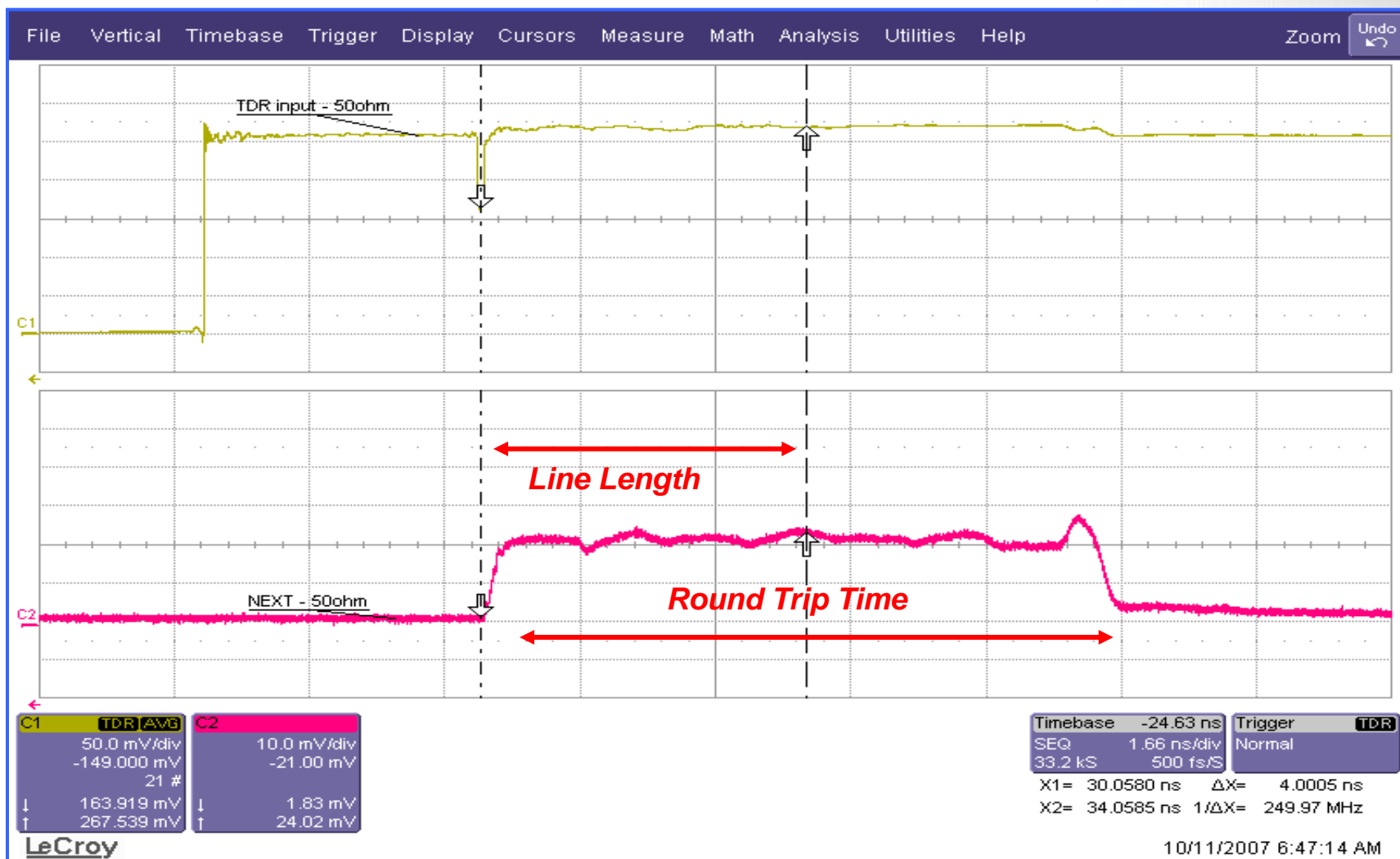
TDR example



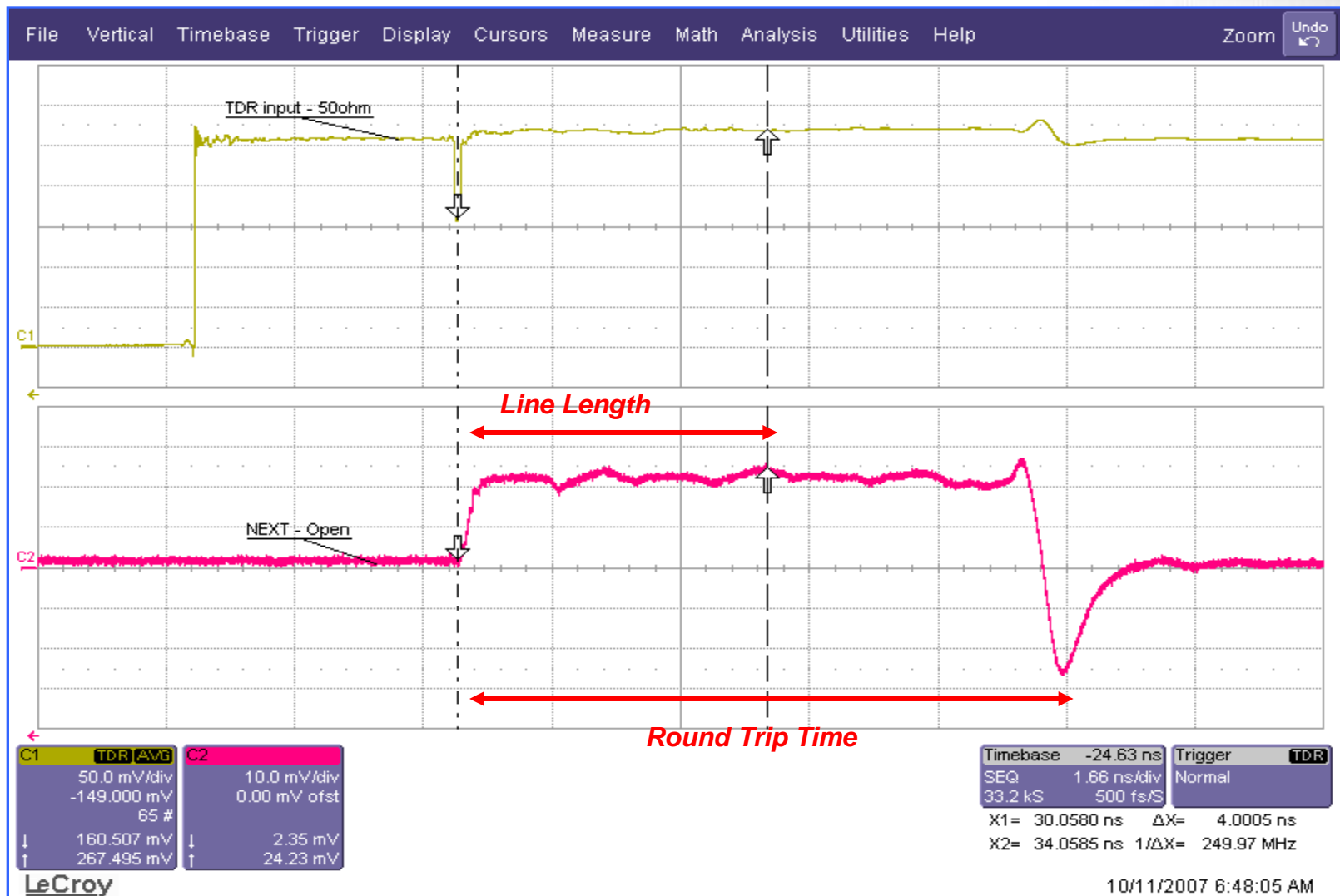
Rise-time Degradation on a 24" Line



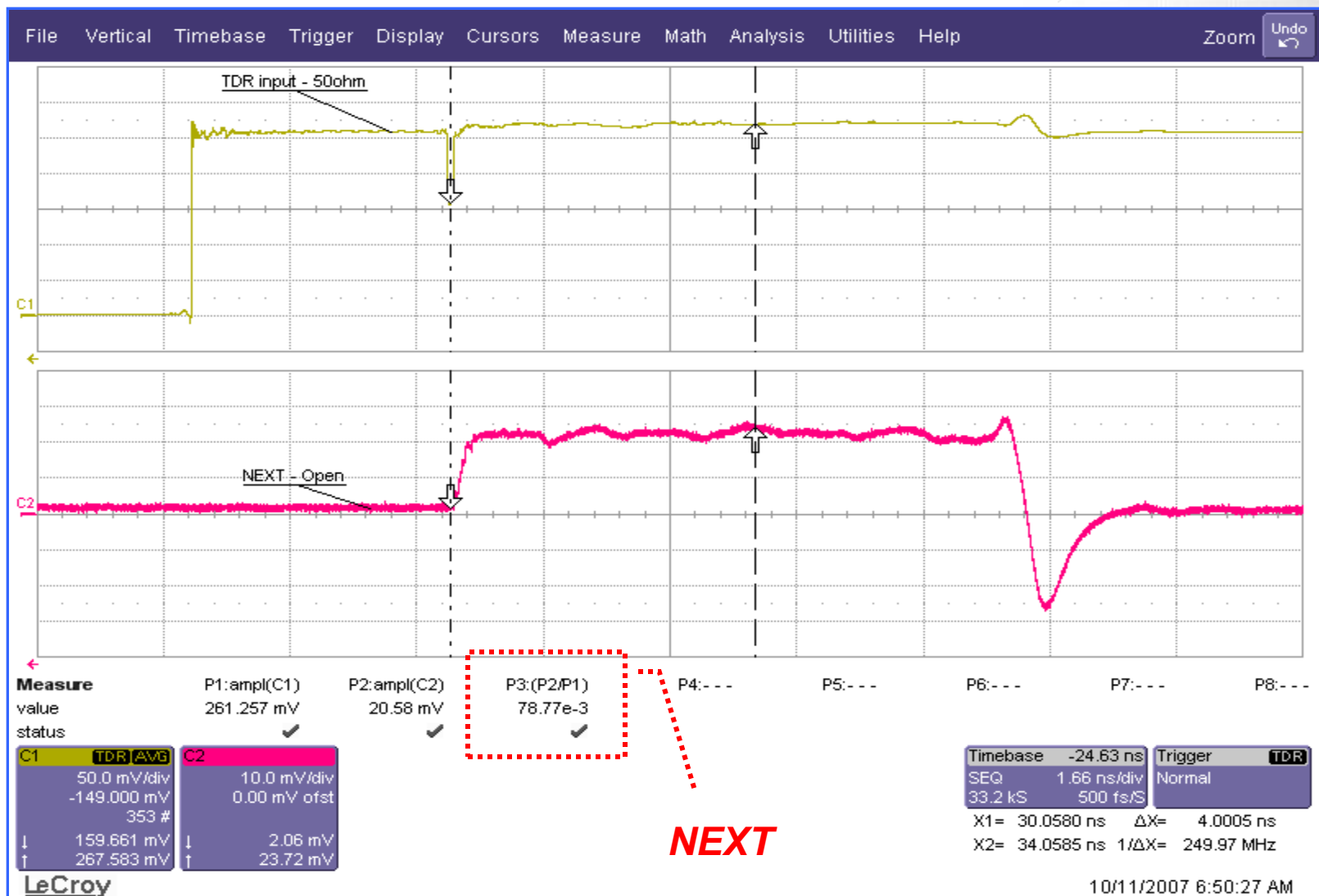
NEXT - Quiet Line @ 50Ω



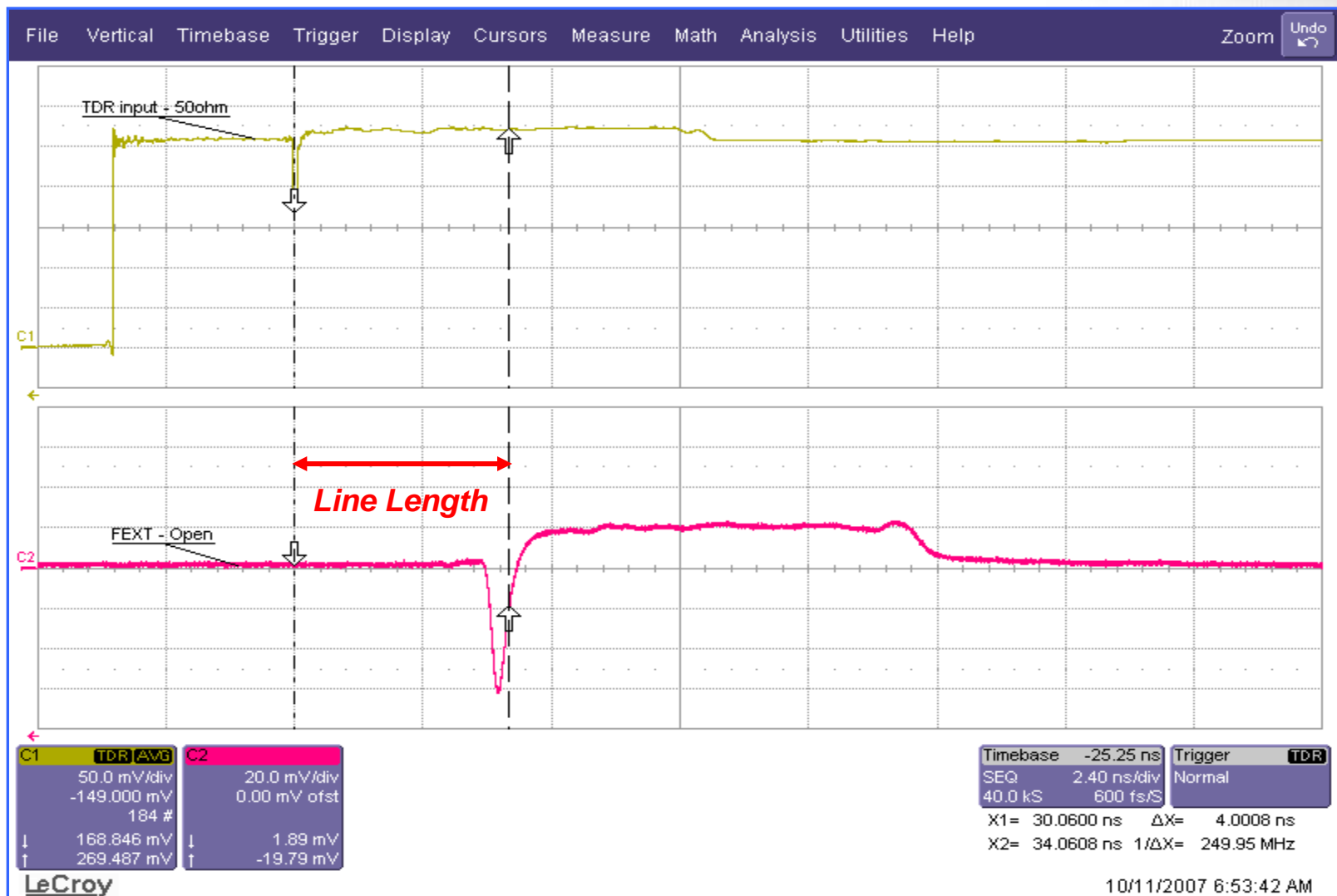
NEXT - Quiet Line Open Terminated



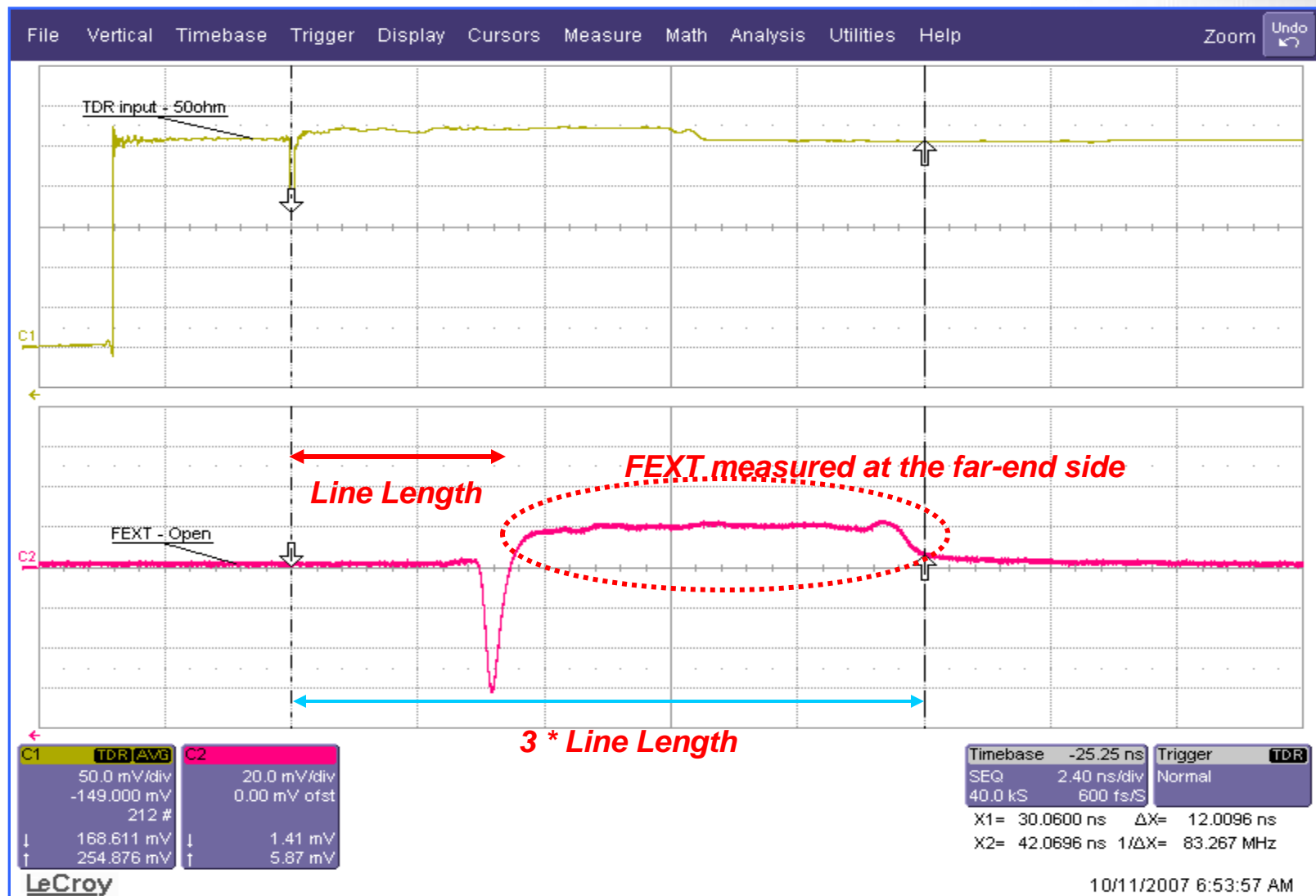
NEXT - Quiet Line Open Terminated readout



FEXT - Quiet Line Open Terminated



FEXT – Quiet Line Open Terminated (cont.)



FEXT - Quiet Line Open Terminated readout

